Search	Notes
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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/510,198	CHEN, WEIBIN	
Examiner	Art Unit	
Jeffrey L. Sterrett	2838	

	SEARCHED		
Class	Subclass	Date	Examiner
363	21.12	1/5/2006	JLS
	21.15		
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	97		
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